

# ***XP1509: Combined $\beta_N$ and $I_i$ control Group Review***

**Dan Boyer**

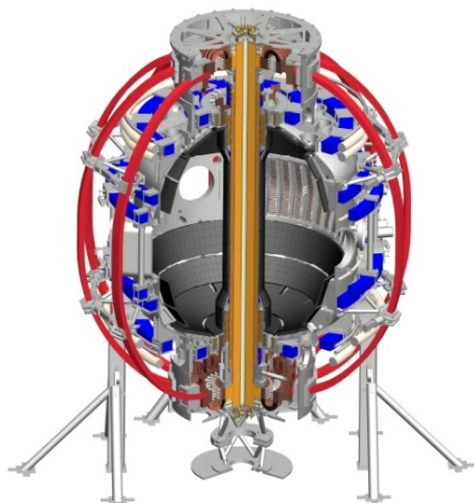
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# XP-1509: Combined $\beta_N$ and $I_i$ control

- Motivation:
  - **Safe operation near stability boundaries**
  - **Controlled, repeatable experiments**
  - **Steer stored thermal/magnetic energy during shut down**
  - **Planning current profile and rotation profile control strategies that will use similar approach (actuators, control laws, software)**
- Goals:
  - **Demonstrate capability of new multi-input-multi-output control algorithm**
  - **Generate control oriented models, assess controllability and limitations**
  - **Attempt to demonstrate control during ramp-up, flat-top, and ramp-down**
- Allocation:
  - **0.75 days, split over multiple days, 1 additional day possible**

# Global parameter control category (“DBC”) in PCS

- Framework for **combined control** of many measurements using many ‘higher level’ actuators
  - **Example measurements:** betaN, li, q0, qmin, etc...
  - **Example actuators:** beams, lp, density, shape control points, etc...
- **Flexible** control implementation
  - **PID control** hand-tunable, similar to ISOFLUX
  - **State-space control** more general, for more complex control laws

# Pre-requisites for running XP

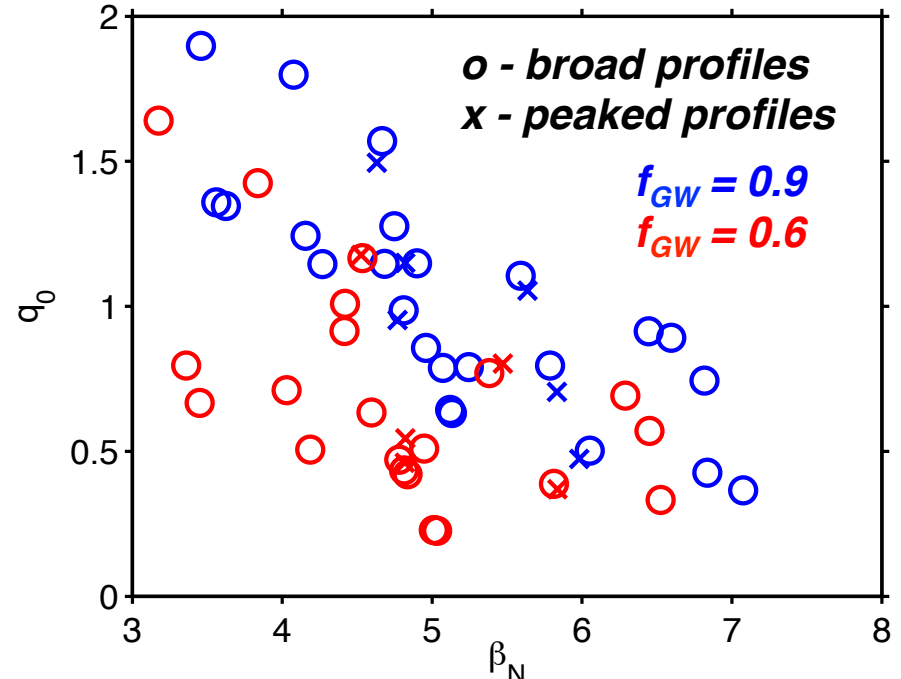
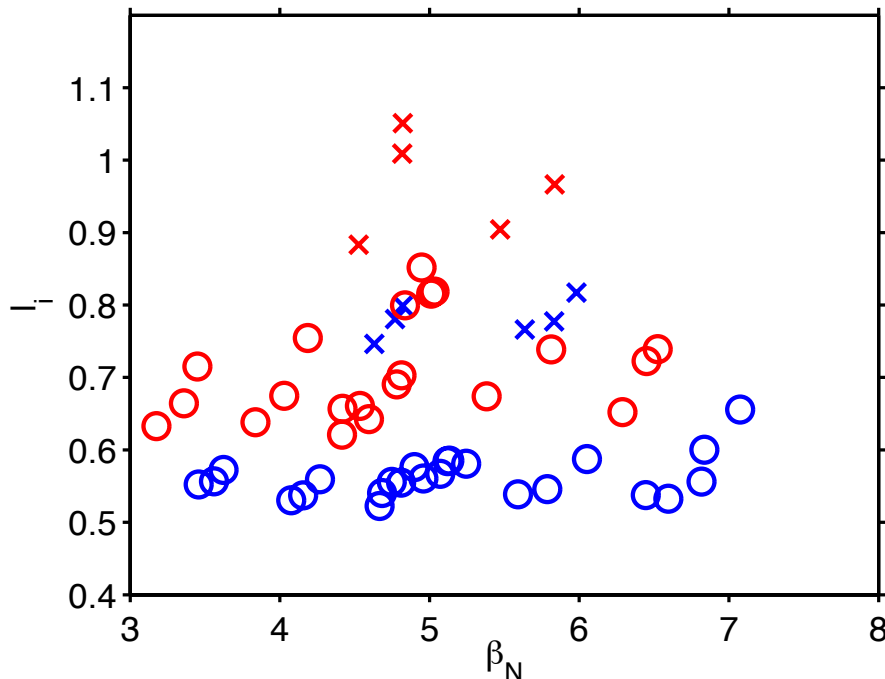
- PCS code updates
  - NBI category
    - Code specifications are written, need to be coded and tested offline
  - GPC category
    - Code specifications are written, need to be coded and tested offline
- rtEFIT commissioning
  - Needed for real-time  $\beta_N$  and  $I_i$
  - ISOFLUX desired for outer gap feedback
    - Could potentially use PCC

# Operational requirements

- Diagnostics
  - Real-time magnetics for rtEFIT (rtEFIT required for real-time  $\beta_N$  and  $I_i$ )
  - Magnetics for **EFIT reconstructions**
  - Profile diagnostics for **TRANSP analysis**
- Hardware requirements
  - **Beams** under PCS control by GPC category
- Analysis during XP
  - Between shots EFIT
  - Between shots TRANSP (optional, but expected to be available)

## Control of $I_i$ may not be easy...

- 30 TRANSP runs with different combinations of beams for beam characterization XP
  - $f_{GW} = 0.9$  and  $0.6$ , 10cm outer gap,  $I_p$  700 - 1000kA,  $B_T$  0.5T - 0.75T
- For  $q_0 > 1$ , very little variation in  $I_i$  with beam mix
- Profile peaking variations may help



# Shot Plan – Step 1: System identification

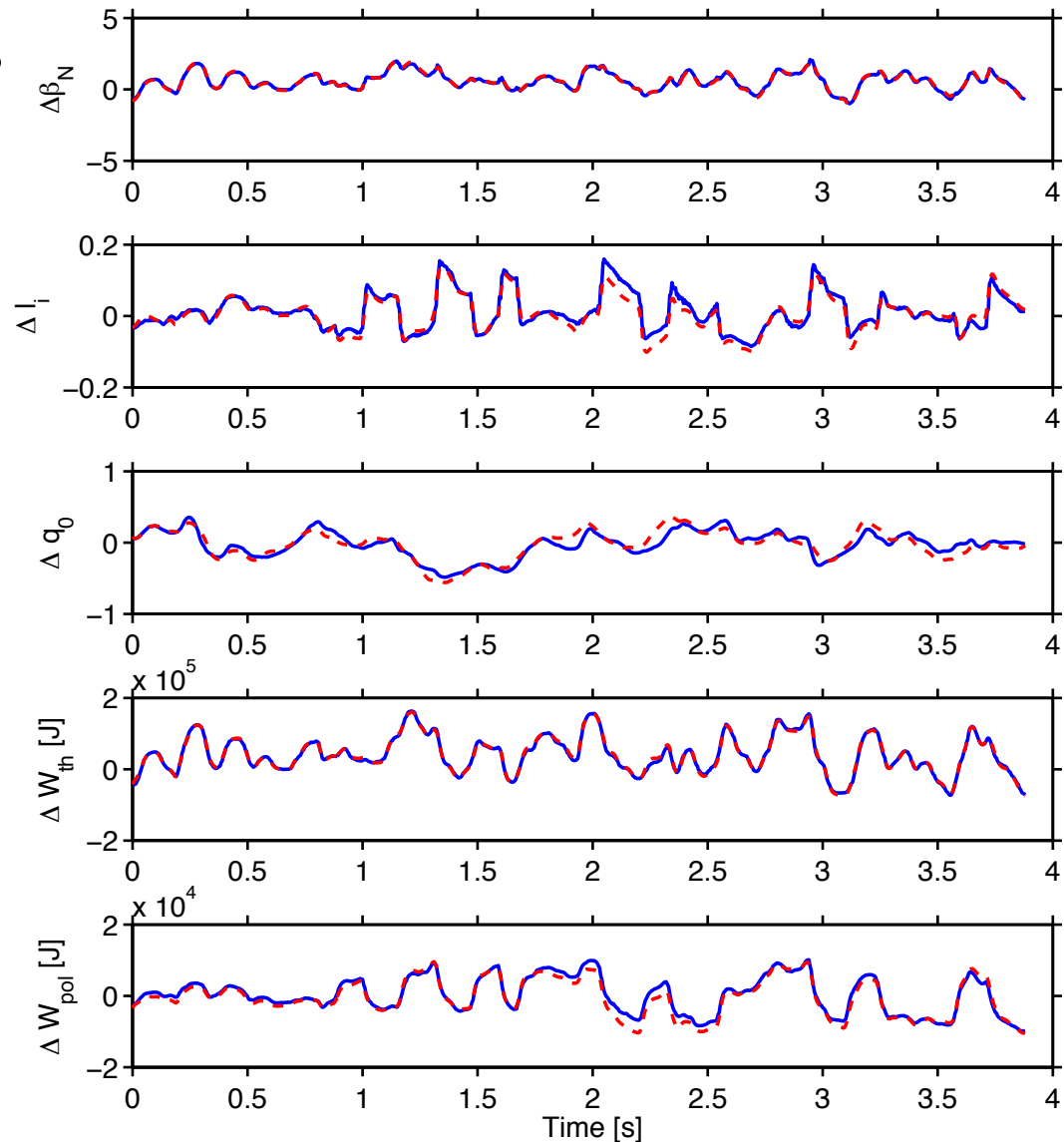
- Establish reference shot
  - >1s flat top, 0.65 T (as high as possible), ~700kA, ~12cm outer gap, fGW as low as possible while keeping  $q_{min}$  above 1
- Conduct modulation around reference for system identification
  - Modulate beams and outer gap early in shot
  - Include plasma current modulation later in shot
    - If discharges are too short, may require separate shots
- Repeat at higher current or lower density reference

**Number of shots: 6-12**

# TRANSP used for preliminary system identification

- Modulated TRANSP runs used to identify linear model
  - TRANSP compared with model prediction
  - Beam and gap modulation only until 1s
  - Current and density modulation 1s to end
- Used for initial controller testing/tuning
- Use to guide system ID shot design

**TRANSP**  
**Model**





# Shot Plan - Step 2: Flattop $\beta_N$ and $I_i$ control, ramp up study

- Initial condition error rejection
  - During ramp-up, vary current ramp rate, beam timing, gap to vary  $I_i$ 
    - Will be used to assess controllability during ramp-up
  - Specify **target trajectory** for  $\beta_N$  and  $I_i$  from the reference shot, activate control shortly after flattop
    - Use **control gains derived from TRANSP** analysis as default
    - If possible, use **gains derived from system identification** shots
- Disturbance rejection
  - Apply an input disturbance (vary feedforward current and/or injected power)
  - Attempt to track reference  $\beta_N$  and  $I_i$
  - If discharge length is long enough, turn off feedback later in shot
    - Demonstrate effect of disturbance, improvement gained with controller
  - Use beam+gap feedback initially, add current later on

**Number of shots: 6-10**

# Shot Plan - Step 3: Ramp up control of $I_i$ , flattop stored thermal and magnetic energy control

- Ramp-up control of  $I_i$ 
  - During ramp-up, use feedback on plasma current or gap request to track  $I_i$  trajectory
    - Initially track reference if repeatability is an issue
    - Later try to track a lower target for vertical stability
- During flattop, switch phases to control thermal and magnetic stored energy
  - Use beam+gap only initially, then add current feedback
  - Initially track reference trajectory
    - Attempt to control during ramp-down
  - Later track target
    - Ramp down to 10% level
    - Ramp down to 20% level

**Number of shots: 6-10**

# Analysis of Results

- EFIT
  - Compare **evolution of  $\beta_N$  and  $I_i$**  to target
  - Assess effect of feedback on **shaping, current profile**
- TRANSP
  - Analyze **heating and current drive**
  - Open and closed loop TRANSP simulations will be compared to experiments to **assess use of TRANSP as a control design tool**
- Control oriented modeling
  - Control oriented q profile modeling efforts (Z. Ilhan, Lehigh U.)